P-Channel Enhancement Mode Field Effect Transistor

Product Summary

V_{DS}	-30 V
I_D	-12 A
$R_{DS(ON)}$(at V_{GS}=-20V)	＜10 m
$R_{DS(ON)}$(at V_{GS}=-10V)	＜12 m
$R_{DS(ON)}$(at V_{GS}=-4.5V)	＜20 m

100% EAS Tested

General Description

Trench Power LV MOSFET technology
High density cell design for Low RDS(ON)
High Speed switching
Moisture Sensitivity Level 3
Epoxy Meets UL 94 V-0 Flammability Rating
Halogen Free

Applications

Battery protection
Power management

Absolute Maximum Ratings (T_A=25℃ unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-source Voltage		V_{DS}	-30	V
Gate-source Voltage		V_{GS}	±25	V
Drain Current	T_A=25℃	I_D	-12	A
	T_A=100℃		-7.5	
Pulsed Drain Current [A]		I_{DM}	-100	A
Avalanche energy [B]		EAS	100	mJ
Total Power Dissipation [C]	T_A=25℃	P_D	2.5	W
	T_A=100℃		1	
Junction and Storage Temperature Range		T_J ,T_{STG}	-55～+150	℃

Thermal resistance

Parameter		Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient [D]	Steady-State	R	40	50	℃/W

Ordering Information

Electrical Characteristics (T_J=25℃ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS}= 0V, I_D=-	-30	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS}=-30V, V_{GS}=0V	-	-	-1	
		V_{DS}=-30V, V_{GS}=0V, Tj=150℃	-	-	-100	
Gate-Body Leakage Current	I_{GSS}	V_{GS}= ±25V, V_{DS}=0V	-	-	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS}= V_{GS}, I_D=-	-1.2	-1.8	-2.8	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	V_{GS}=-20V, I_D=-12A	-	7.5	10	
		V_{GS}=-10V, I_D=-12A	-	9	12	
		V_{GS}=-6V, I_D=-10A	-	11	15	
		V_{GS}=-4.5V, I_D=-10A	-	14.5	20	
Diode Forward Voltage	V_{SD}	I_S=-12A, V_{GS}=0V	-	-0.85	-1.2	V
Gate resistance	R_G	f=1MHz	-	16	-	
Maximum Body-Diode Continuous Current	I_S		-	-	-12	A
Dynamic Parameters						
Input Capacitance	C_{iss}	V_{DS}=-15V, V_{GS}=0V, f=1MHz	-	1860	-	pF
Output Capacitance	C_{oss}		-	310	-	
Reverse Transfer Capacitance	C_{rss}		-	280	-	
Switching Parameters						
Total Gate Charge	Q_g	V_{GS}=-10V, V_{DS}=-15V, I_D=-12A	-	38	-	nC
Gate-Source Charge	Q_{gs}		-	5	-	
Gate-Drain Charge	Q_{gd}		-	10	-	
Reverse Recovery Charge	Q_{rr}	I_F=-12A, di/dt=100A/us	-	19	-	nC
Reverse Recovery Time	t_{rr}		-	40	-	ns
Turn-on Delay Time	$t_{D(on)}$	V_{GS}=-10V, V_{DD}=-15V, ID=-12A R_{GEN}=2.3	-	8	-	ns
Turn-on Rise Time	t_r		-	6	-	
Turn-off Delay Time	$t_{D(off)}$		-	95	-	
Turn-off fall Time	t_f		-	62	-	

A. Repetitive rating; pulse width limited by max. junction temperature.

B. T_J=25℃, V_{DD}=-20V, V_G=-10V, R_G 0.5mH, IAS=-20A.

C. P_d is based on max. junction temperature, using junction-case and junction-ambient thermal resistance.

D. The value of R is measured with the device mounted on 1 in^2 FR-4 board with 2oz. Copper, in the still air environment with T_A =25℃. The maximum allowed junction temperature of 150℃. The value in any given application depends on the user's specific board design.

Typical Electrical and Thermal Characteristics Diagrams

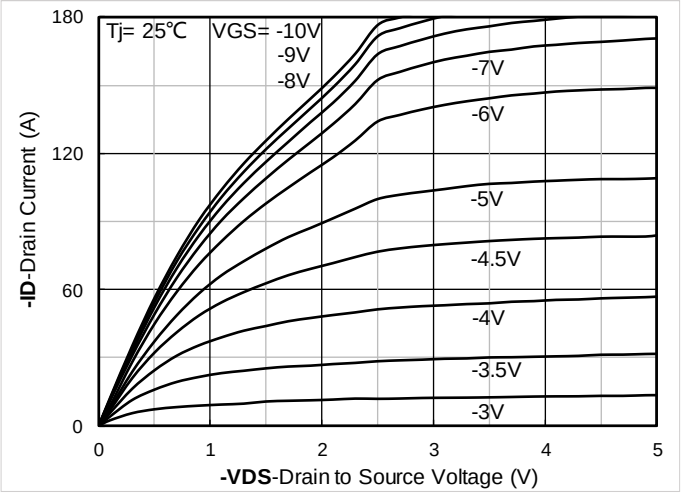


Figure 1. Output Characteristics

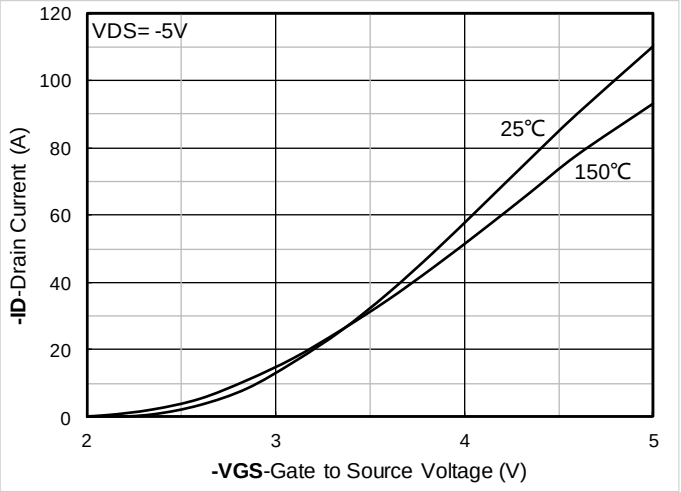


Figure 2. Transfer Characteristics

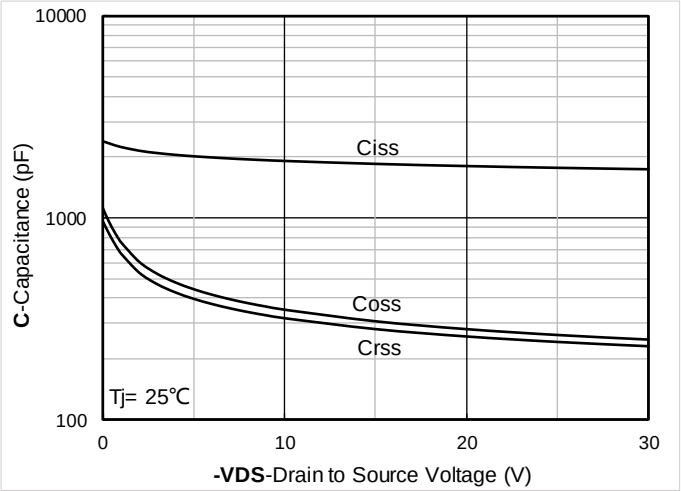


Figure 3. Capacitance Characteristics

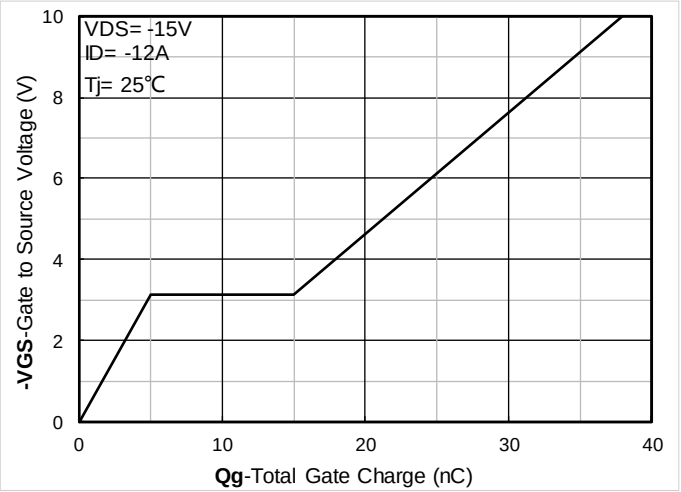


Figure 4. Gate Charge

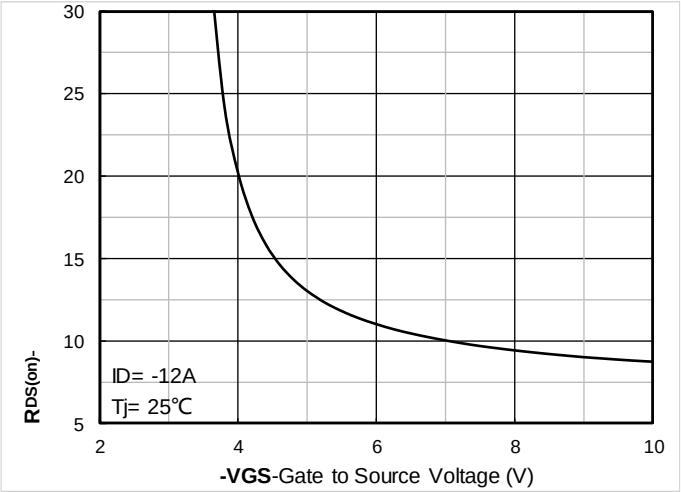


Figure 5. On-Resistance vs Gate to Source Voltage

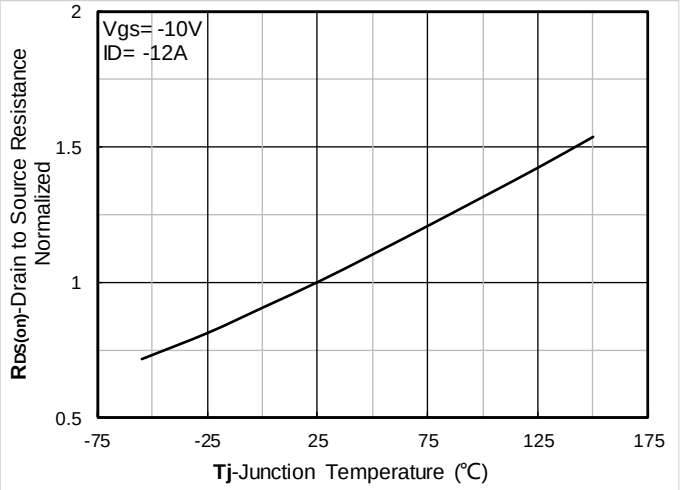


Figure 6. Normalized On-Resistance

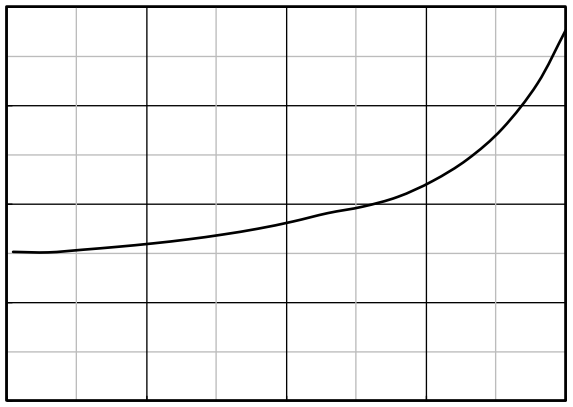


Figure 7. $R_{DS(on)}$ VS Drain Current

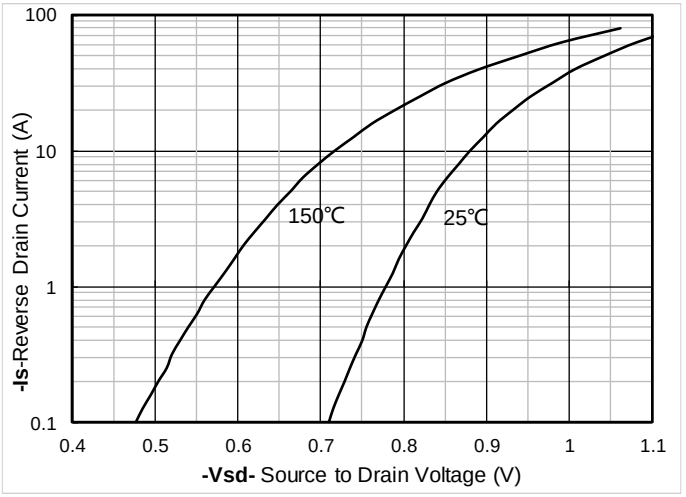


Figure 8. Forward characteristics of reverse diode

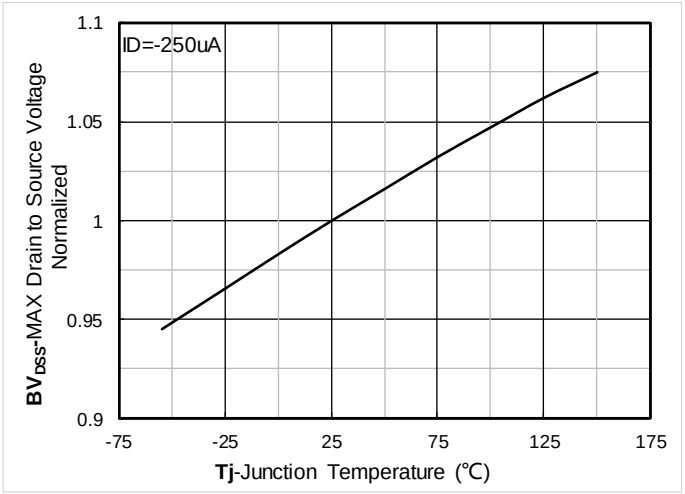


Figure 9. Normalized breakdown voltage

Figure 10. Normalized Threshold voltage

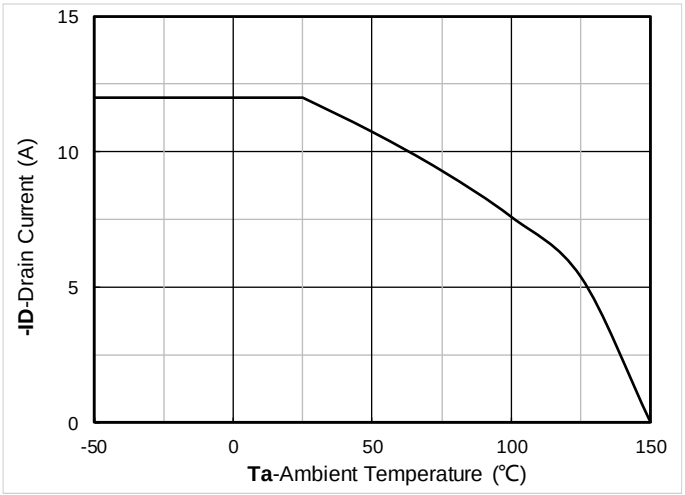


Figure 11. Current dissipation

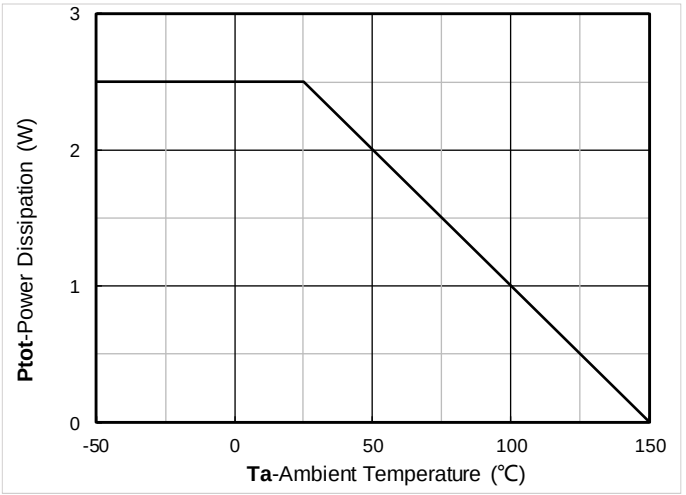


Figure 12. Power dissipation

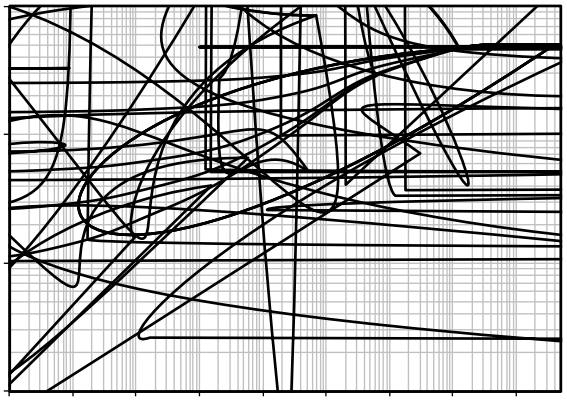


Figure 13. Maximum Transient Thermal Impedance

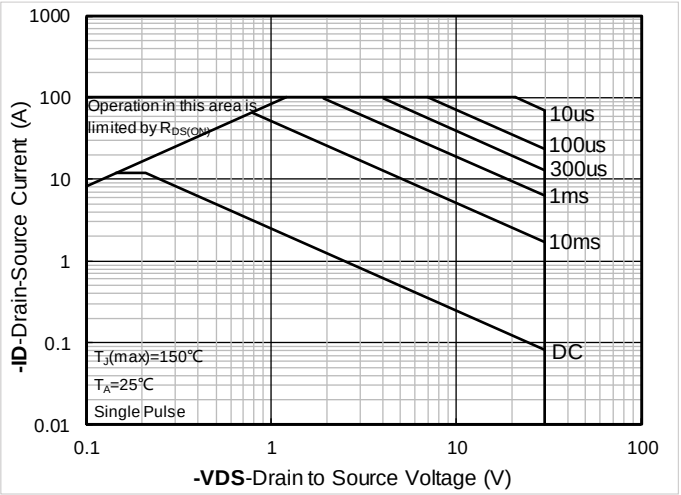
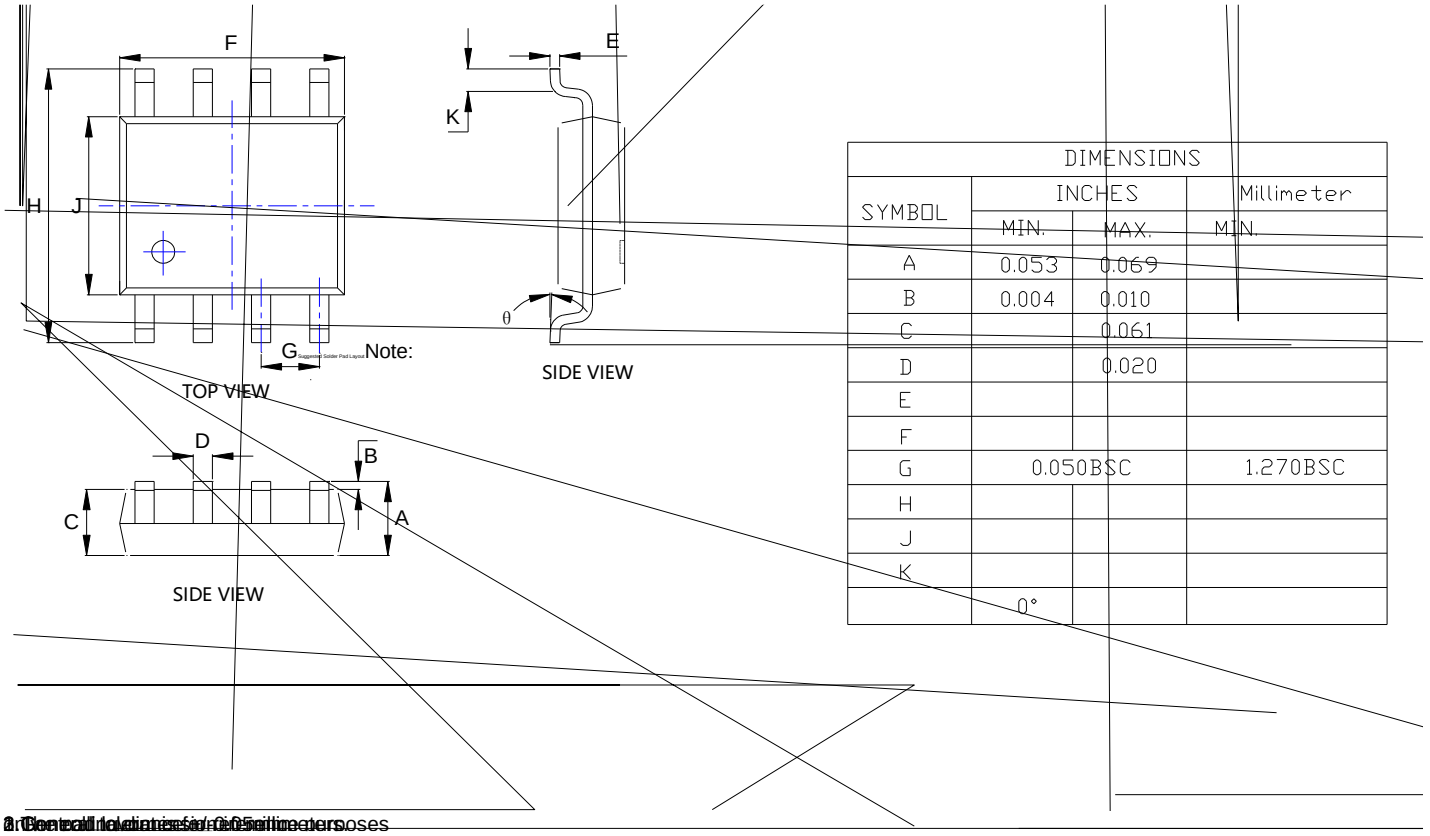


Figure 14. Safe Operation Area

SOP8 Package information



DIMENSIONS			
SYMBOL	INCHES		Millimeter
	MIN.	MAX.	MIN.
A	0.053	0.069	
B	0.004	0.010	
C		0.061	
D		0.020	
E			
F			
G	0.050BSC		1.270BSC
H			
J			
K			
	0°		

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